Application/Control No.	Applicant(s)/Patent under Reexamination	
10/511,678	NAKAYAMA ET AL.	
Examiner	Art Unit	
Son T. Nguyen	3643	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
previous search updated	10/14/2007	STN		